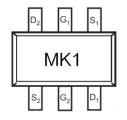
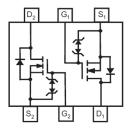


Main Product Characteristics:

V _{DSS}	20V
R _{DS} (on)	0.4Ω (typ.)
I _D	0.54A







SOT-363

Marking and Pin
Assignment

Schematic Diagram

Features and Benefits:

- Advanced MOSFET process technology
- Special designed for PWM, load switching and general purpose applications
- Ultra low on-resistance with low gate charge
- Fast switching and reverse body recovery
- 150°C operating temperature



Description:

It utilizes the latest processing techniques to achieve the high cell density and reduces the on-resistance with high repetitive avalanche rating. These features combine to make this design an extremely efficient and reliable device for use in power switching application and a wide variety of other applications.

Absolute max Rating:

Parameter	Symbol	Limit	Unit
Drain-Source Voltage	VDS	20	V
Gate-Source Voltage	VGS	±8	V
Proin Current Continuous@ Current Bulged (Note 1)	I _D	0.54	А
Drain Current-Continuous@ Current-Pulsed (Note 1)	I _{DM}	1.5	А
Maximum Power Dissipation	P _D	0.2	W
Operating Junction and Storage Temperature Range	T_{J} , T_{STG}	-55 To 150	$^{\circ}$

Thermal Resistance

Thermal Resistance, Junction-to-Ambient (Note 2)	$R_{\theta JA}$	625	°C /W
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Electrical Characteristics @T_A=25℃ unless otherwise specified

Symbol	Parameter	Min.	Тур.	Max.	Units	Conditions
V _{(BR)DSS}	Drain-to-Source breakdown voltage	20	_	_	V	$V_{GS} = 0V, I_D = 250\mu A$
		_	0.4	0.55	Ω	V_{GS} =4.5 V , I_D = 0.54 A
R _{DS(on)}	Static Drain-to-Source on-resistance	_	0.5	0.7	Ω	$V_{GS}=2.5V, I_D=0.5A$
		_	0.7	0.9	Ω	V_{GS} =1.8 V , I_{D} = 0.35 A
$V_{GS(th)}$	Gate threshold voltage	0.5	_	1.0	V	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$
I _{DSS}	Drain-to-Source leakage current	_	_	1	μA	$V_{DS} = 20V, V_{GS} = 0V$
1	SS Gate-to-Source forward leakage		_	±1		$V_{GS} = \pm 4.5V$
I _{GSS}			_	±10	μA	$V_{GS} = \pm 8V$
C _{iss}	Input capacitance	_	87	_		V _{GS} = 0V
Coss	Output capacitance	_	17	_	pF	V _{DS} = 16V
C _{rss}	Reverse transfer capacitance	_	10	_		f = 1MHz

Source-Drain Ratings and Characteristics

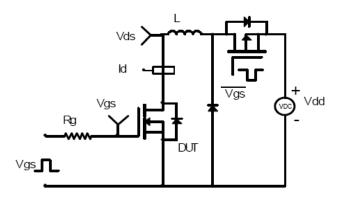
Symbol	Parameter	Min.	Тур.	Max.	Units	Conditions
	Continuous Source Current			0.54	^	MOSFET symbol
Is	(Body Diode)	_	_	0.54	A	showing the
I _{SM}	Pulsed Source Current		_	1.5	А	integral reverse
	(Body Diode)	_				p-n junction diode.
$V_{\scriptscriptstyle{SD}}$	Diode Forward Voltage	_	-	1.3	V	I _S =0.12A, V _{GS} =0V

Version: 1.1

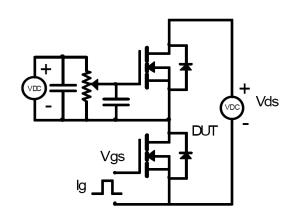


Test circuits and Waveforms

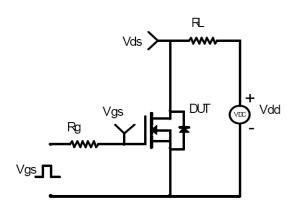
EAS Test Circuit



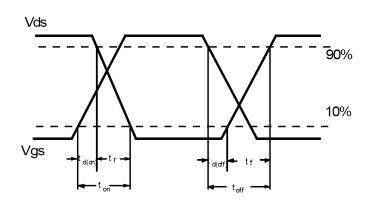
Gate charge test circuit



Switching Time Test Circuit



Switching Waveforms



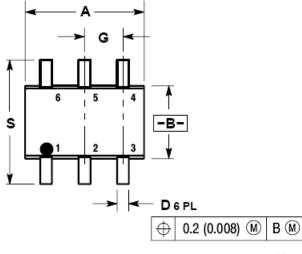
Notes:

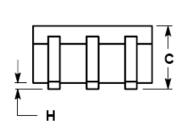
- ①Calculated continuous current based on maximum allowable junction temperature.
- ②Repetitive rating; pulse width limited by max. junction temperature.
- ③The power dissipation PD is based on max. junction temperature, using junction-to-case thermal resistance.
- 4The value of $R_{\texttt{6JA}}$ is measured with the device mounted on 1 in 2 FR-4 board with 2oz. Copper, in a still air environment with TA =25°C

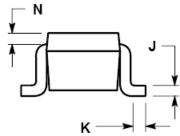


Mechanical Data:

SOT-363(SC-88) PACKAGE OUTLINE DIMENSION







NOTES:

- 1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
- 2. CONTROLLING DIMENSION: INCH.
- 3. 419B-01 OBSOLETE, NEW STANDARD 419B-02.

	INC	HES	MILLIN	IETERS
DIM	MIN	MAX	MIN	MAX
Α	0.071	0.087	1.80	2.20
В	0.045	0.053	1.15	1.35
С	0.031	0.043	0.80	1.10
D	0.004	0.012	0.10	0.30
G	0.026	BSC	0.65	BSC
Н		0.004		0.10
J	0.004	0.010	0.10	0.25
K	0.004	0.012	0.10	0.30
N	0.008	3 REF	0.20	REF
S	0.079	0.087	2.00	2.20



Ordering and Marking Information

Device Marking: MK1

Package (Available)
SOT-363(SC-88)
Operating Temperature Range
C: -55 to 150 °C

Devices per Unit

Package	Units/	Tapes/Inner	Units/Inner	Inner	Units/
Type	Tape	Box	Box	Boxes/Carton	Carton
				Box	Box

Reliability Test Program

Test Item	Conditions	Duration	Sample Size
High	T _j =125℃ to 150℃ @	168 hours	3 lots x 77 devices
Temperature	80% of Max	500 hours	
Reverse	V _{DSS} /V _{CES} /VR	1000 hours	
Bias(HTRB)			
High	T _j =150℃ @ 100% of	168 hours	3 lots x 77 devices
Temperature	Max V _{GSS}	500 hours	
Gate		1000 hours	
Bias(HTGB)			



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